

NTHD5902T1

Power MOSFET Dual N-Channel ChipFET™

2.9 Amps, 30 Volts

Features

- Low $R_{DS(on)}$ for Higher Efficiency
- Miniature ChipFET Surface Mount Package Saves Board Space

Applications

- Power Management in Portable and Battery-Powered Products; i.e., Cellular and Cordless Telephones and PCMCIA Cards



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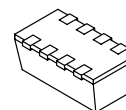
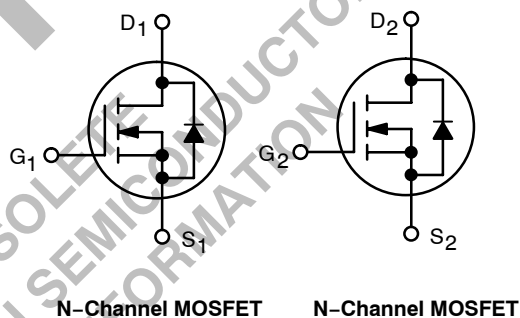
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DUAL N-CHANNEL
2.9 AMPS, 30 VOLTS
 $R_{DS(on)} = 85 \text{ m}\Omega$

MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

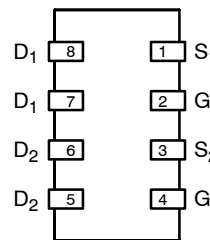
Rating	Symbol	5 secs	Steady State	Unit
Drain-Source Voltage	V_{DS}	30		V
Gate-Source Voltage	V_{GS}	± 20		V
Continuous Drain Current ($T_J = 150^\circ\text{C}$) (Note 1) $T_A = 25^\circ\text{C}$ $T_A = 85^\circ\text{C}$	I_D	± 3.9 ± 2.8	± 2.9 ± 2.1	A
Pulsed Drain Current	I_{DM}	± 10		A
Continuous Source Current (Diode Conduction) (Note 1)	I_S	1.8	0.9	A
Maximum Power Dissipation (Note 1) $T_A = 25^\circ\text{C}$ $T_A = 85^\circ\text{C}$	P_D	2.1 1.1	1.1 0.6	W
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to +150		$^\circ\text{C}$

1. Surface Mounted on 1" x 1" FR4 Board.

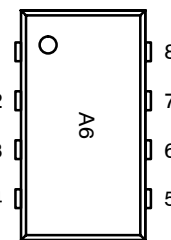


ChipFET
CASE 1206A
STYLE 2

PIN CONNECTIONS



MARKING DIAGRAM



A6 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping
NTHD5902T1	ChipFET	3000/Tape & Reel

NTHD5902T1

THERMAL CHARACTERISTICS

Characteristic	Symbol	Typ	Max	Unit
Maximum Junction-to-Ambient (Note 2) $t \leq 5$ sec Steady State	R_{thJA}	50 90	60 110	$^{\circ}\text{C/W}$
Maximum Junction-to-Foot Steady State	R_{thJF}	30	40	$^{\circ}\text{C/W}$

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
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Static

Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	1.0	–	–	V
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	–	–	± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$	–	–	1.0	μA
		$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 85^{\circ}\text{C}$	–	–	5.0	
On-State Drain Current (Note 3)	$I_{D(on)}$	$V_{DS} \geq 5.0 \text{ V}, V_{GS} = 10 \text{ V}$	10	–	–	A
Drain-Source On-State Resistance (Note 3)	$r_{DS(on)}$	$V_{GS} = 10 \text{ V}, I_D = 2.9 \text{ A}$	–	0.072	0.085	Ω
		$V_{GS} = 4.5 \text{ V}, I_D = 2.2 \text{ A}$	–	0.120	0.143	
Forward Transconductance (Note 3)	g_{fs}	$V_{DS} = 15 \text{ V}, I_D = 2.9 \text{ A}$	–	20	–	S
Diode Forward Voltage (Note 3)	V_{SD}	$I_S = 0.9 \text{ A}, V_{GS} = 0 \text{ V}$	–	0.8	1.2	V

Dynamic (Note 4)

Total Gate Charge	Q_g	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 2.9 \text{ A}$	–	5.0	7.5	nC
Gate-Source Charge	Q_{gs}		–	0.8	–	
Gate-Drain Charge	Q_{gd}		–	1.0	–	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 15 \text{ V}, R_L = 15 \Omega, I_D = 1.0 \text{ A}, V_{GEN} = 10 \text{ V}, R_G = 6 \Omega$	–	7.0	11	ns
Rise Time	t_r		–	12	18	
Turn-Off Delay Time	$t_{d(off)}$		–	12	18	
Fall Time	t_f		–	7.0	11	
Source-Drain Reverse Recovery Time	t_{rr}	$I_F = 0.9 \text{ A}, di/dt = 100 \text{ A}/\mu\text{s}$	–	40	80	

2. Surface Mounted on 1" x 1" FR4 Board.

3. Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2\%$.

4. Guaranteed by design, not subject to production testing.

TYPICAL ELECTRICAL CHARACTERISTICS

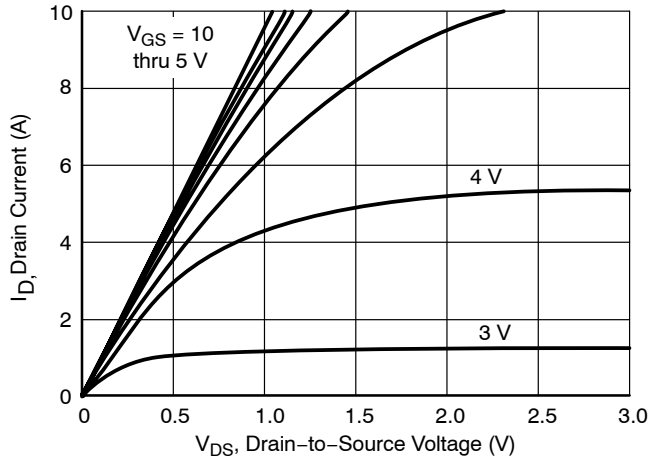


Figure 1. Output Characteristics

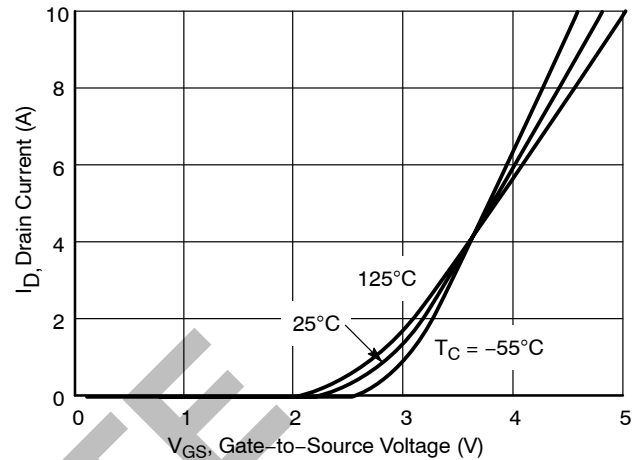


Figure 2. Transfer Characteristics

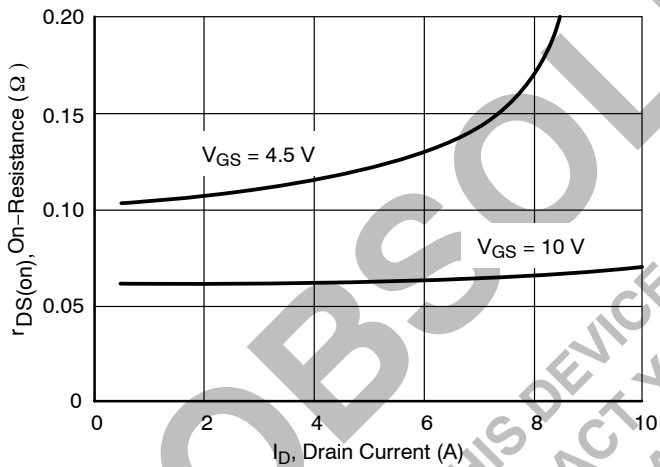


Figure 3. On-Resistance vs. Drain Current

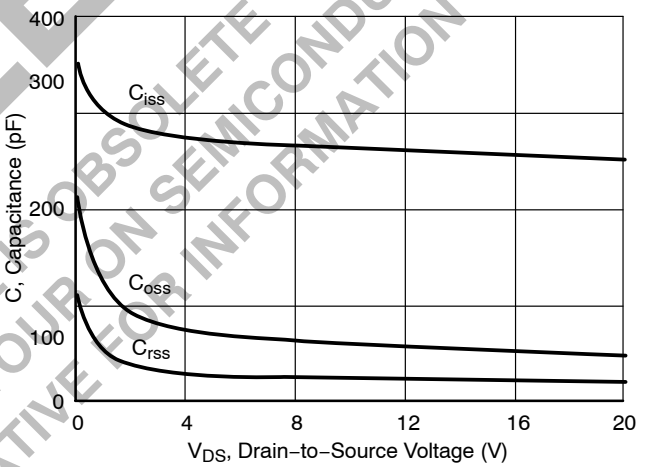


Figure 4. Capacitance

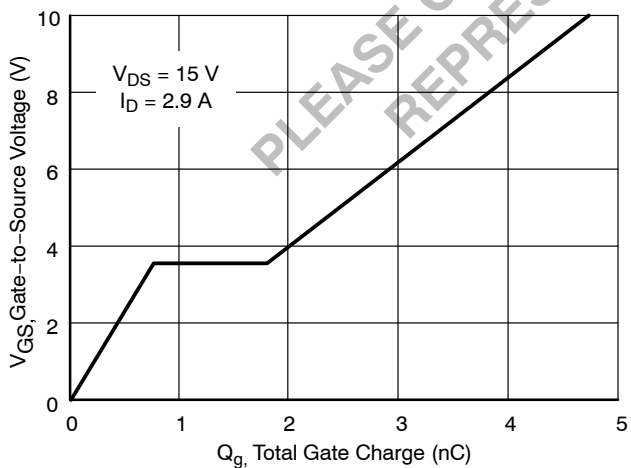


Figure 5. Gate Charge

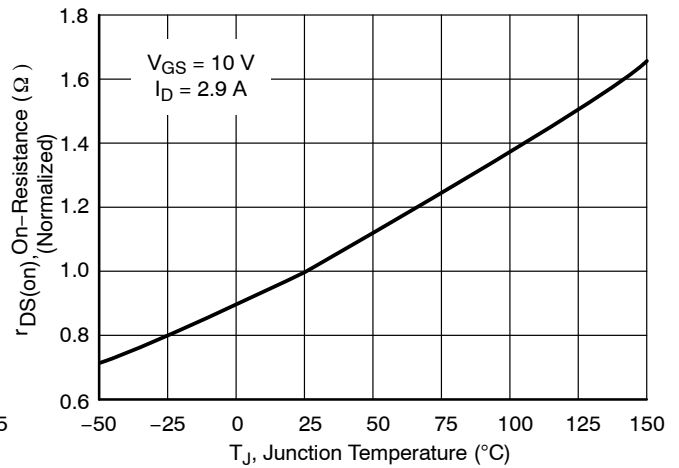


Figure 6. On-Resistance vs. Junction Temperature

TYPICAL ELECTRICAL CHARACTERISTICS

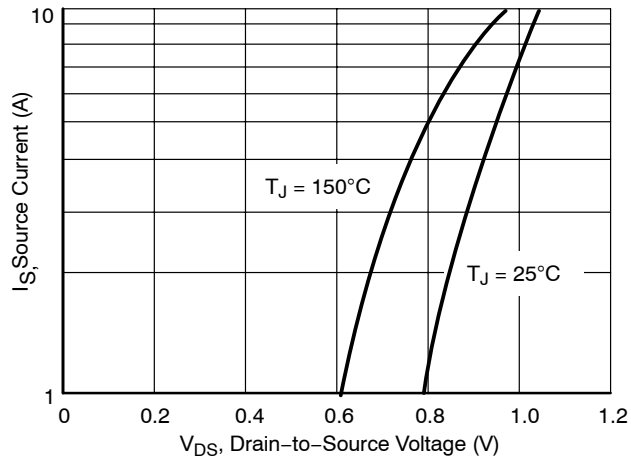


Figure 7. Source-Drain Diode Forward Voltage

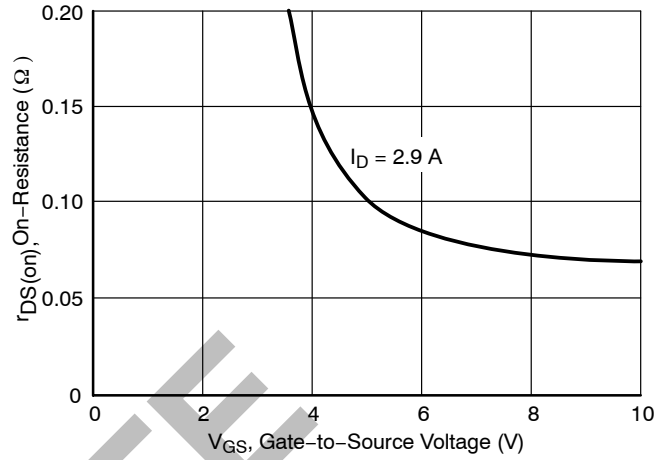


Figure 8. On-Resistance vs. Gate-to-Source Voltage

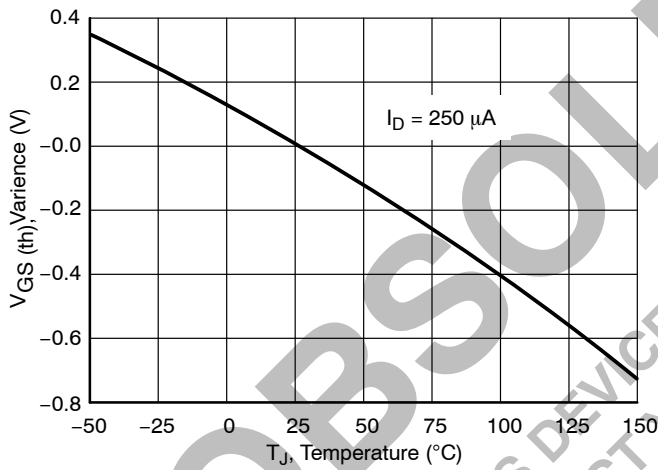


Figure 9. Threshold Voltage

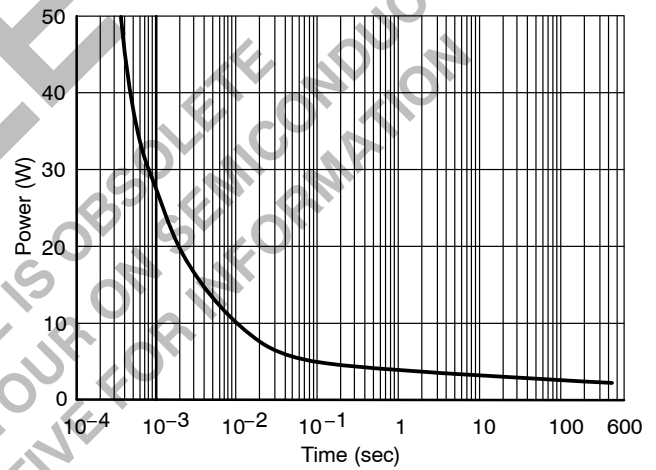


Figure 10. Single Pulse Power

TYPICAL ELECTRICAL CHARACTERISTICS

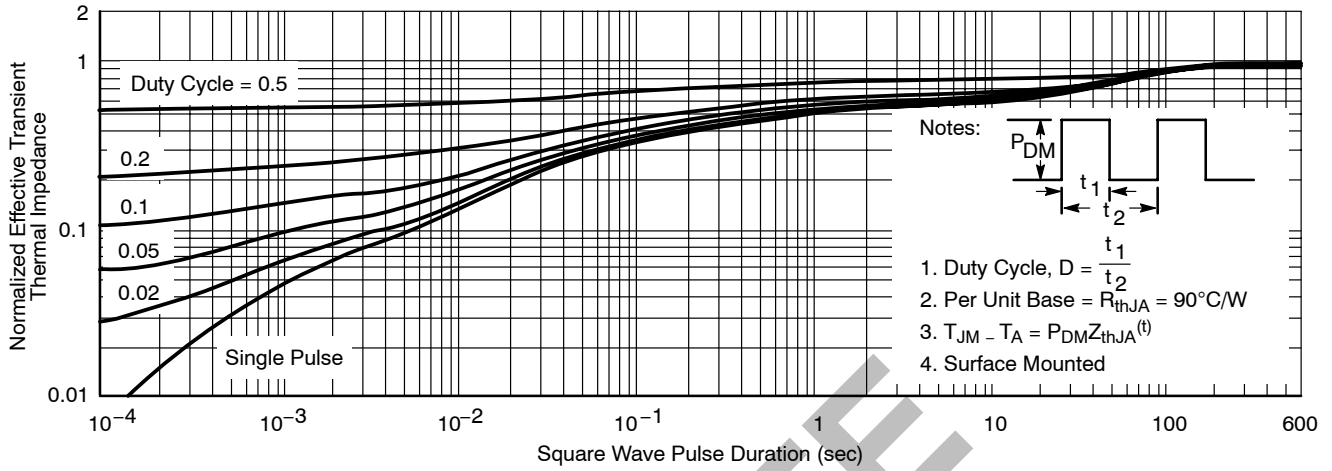


Figure 11. Normalized Thermal Transient Impedance, Junction-to-Ambient

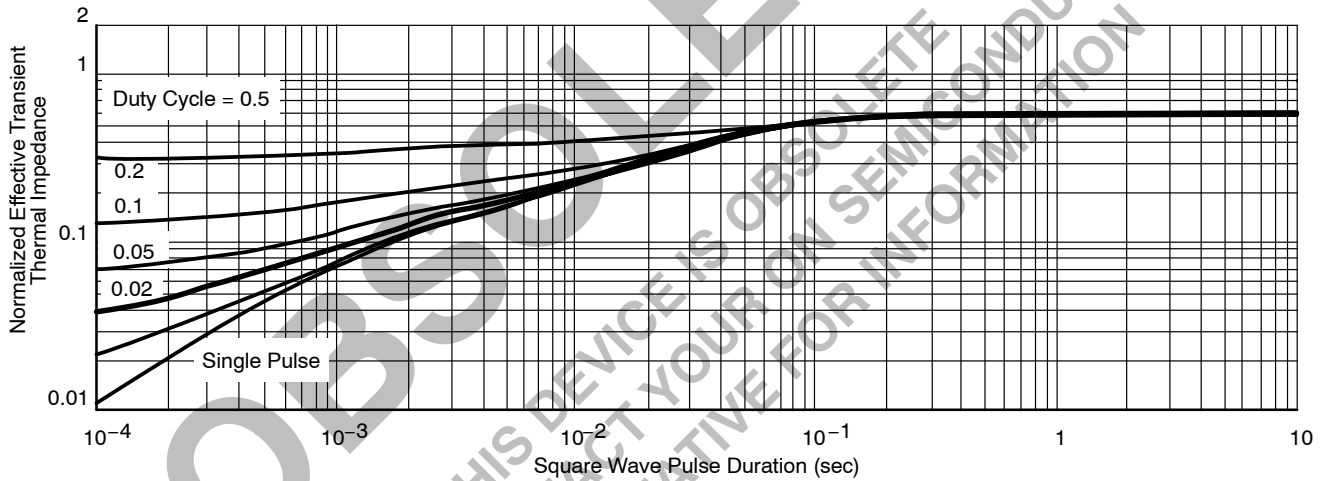


Figure 12. Normalized Thermal Transient Impedance, Junction-to-Foot

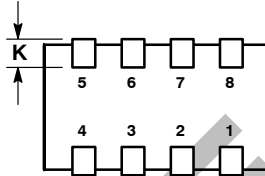
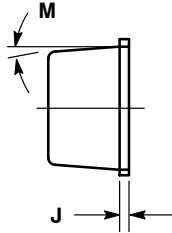
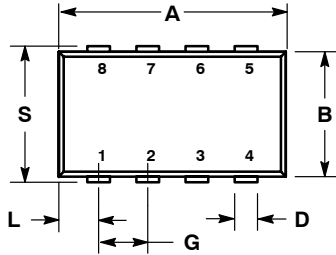
Notes

OBSOLETE
THIS DEVICE IS OBSOLETE
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NTHD5902T1

PACKAGE DIMENSIONS

ChipFET
CASE 1206A-03
ISSUE D



 0.05 (0.002)

STYLE 2:
PIN 1. SOURCE 1
2. GATE 1
3. SOURCE 2
4. GATE 2
5. DRAIN 2
6. DRAIN 2
7. DRAIN 1
8. DRAIN 1

NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER.
- MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
- LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM.
- DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
- NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.
- 1206A-01 AND 1206A-02 OBSOLETE. NEW STANDARD IS 1206A-03.

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.95	3.10	0.116	0.122
B	1.55	1.70	0.061	0.067
C	1.00	1.10	0.039	0.043
D	0.25	0.35	0.010	0.014
G	0.65 BSC		0.025 BSC	
J	0.10	0.20	0.004	0.008
K	0.28	0.42	0.011	0.017
L	0.55 BSC		0.022 BSC	
M	5 ° NOM		5 ° NOM	
S	1.80	2.00	0.072	0.080

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